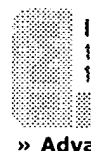


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L1	50194	(Cu or copper) and (cap or capping)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/04 13:03
L2	13971	1 and (oxidiz\$6 or oxidat\$6 or CuO or Cu2O or ((Cu or copper or cupric) adj oxide))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/04 13:04
L3	6483	1 and (CMP or polish\$6)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/04 13:04
L4	3260	3 and 2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/04 13:05
L5	3205	4 and (@ad<="20040128" or @rlad<="20040128")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/04 13:06
L6	2312	5 and semiconductor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/04 13:06
L7	2109	6 and (strength or hardness or nitrid\$6 or boroniz\$6 or phosphorat\$6 or CuN or CuP or CuB)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/04 13:08

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Example: optical <and> (fiber <or> fibre) <in> ti

- 3) Limit the results by selecting Search Options.

- 4) Click Search. See [Search Examples](#)

(cu* or copper*) and (cmp or polish*) and (cap or capping or nitrid* or boron* or phosphorat* or cun or cup or

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